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Kind regards,

Team Nexperia



PBSS305PX

80 V, 4.0 A PNP low V_{CEsat} (BISS) transistor Rev. 02 — 8 December 2009

Product data sheet

Product profile 1.

1.1 General description

PNP low V_{CEsat} Breakthrough In Small Signal (BISS) transistor in a SOT89 (SC-62/TO-243) small and flat lead Surface-Mounted Device (SMD) plastic package.

NPN complement: PBSS305NX.

1.2 Features

- Low collector-emitter saturation voltage V_{CEsat}
- High collector current capability I_C and I_{CM}
- High collector current gain (h_{FE}) at high I_C
- High efficiency due to less heat generation
- Smaller required Printed-Circuit Board (PCB) area than for conventional transistors

1.3 Applications

- High-voltage DC-to-DC conversion
- High-voltage MOSFET gate driving
- High-voltage motor control
- High-voltage power switches (e.g. motors, fans)
- Automotive applications

1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{CEO}	collector-emitter voltage	open base	-	-	-80	V
I _C	collector current		-	-	-4	Α
I _{CM}	peak collector current	$\begin{array}{l} \text{single pulse;} \\ t_p \leq 1 \text{ ms} \end{array}$	-	-	-8	Α
R _{CEsat}	collector-emitter saturation resistance	$I_C = -4 \text{ A};$ $I_B = -200 \text{ mA}$	[1] -	58	83	mΩ

^[1] Pulse test: $t_p \le 300 \ \mu s; \ \delta \le 0.02.$



2. Pinning information

Table 2. Pinning

I do L	· ····································		
Pin	Description	Simplified outline	Symbol
1	emitter		
2	collector		2
3	base	3 2 1	3 — 1
			006aaa231

3. Ordering information

Table 3. Ordering information

Type number	Package	Package					
	Name	Description	Version				
PBSS305PX	SC-62	plastic surface-mounted package; collector pad for good heat transfer; 3 leads	SOT89				

4. Marking

Table 4. Marking codes

Type number	Marking code ^[1]
PBSS305PX	*5M

[1] * = -: made in Hong Kong

* = p: made in Hong Kong

* = t: made in Malaysia

* = W: made in China

Product data sheet

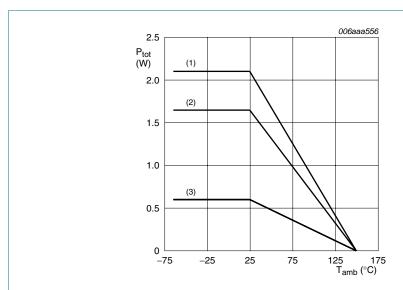
3 of 15

5. **Limiting values**

Table 5. **Limiting values** In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{CBO}	collector-base voltage	open emitter	-	-80	V
V_{CEO}	collector-emitter voltage	open base	-	-80	V
V_{EBO}	emitter-base voltage	open collector	-	-5	V
Ic	collector current		-	-4	Α
I _{CM}	peak collector current	single pulse; $t_p \le 1 \text{ ms}$	-	-8	Α
P _{tot}	total power dissipation	$T_{amb} \le 25 ^{\circ}C$	<u>[1]</u> _	0.6	W
			[2] _	1.65	W
			[3] _	2.1	W
Tj	junction temperature		-	150	°C
T _{amb}	ambient temperature		-65	+150	°C
T _{stg}	storage temperature		-65	+150	°C
•					

- Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm².
- Device mounted on a ceramic PCB, Al₂O₃, standard footprint.



- (1) Ceramic PCB, Al₂O₃, standard footprint
- (2) FR4 PCB, mounting pad for collector 6 cm²
- FR4 PCB, standard footprint

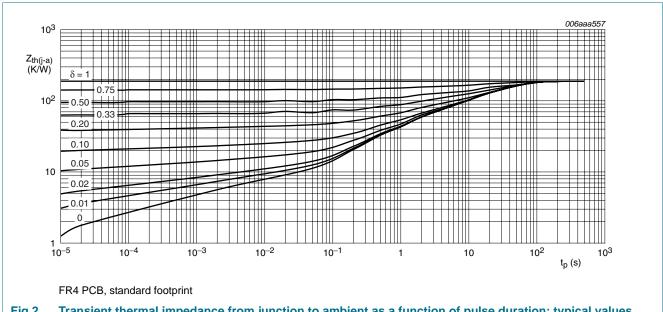
Power derating curves Fig 1.

Thermal characteristics 6.

Table 6. Thermal characteristics

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
R _{th(j-a)}	thermal resistance from junction to ambient		[1]	-	-	208	K/W
			[2]	-	-	76	K/W
			[3]	-	-	60	K/W
R _{th(j-sp)}	thermal resistance from junction to solder point			-	-	20	K/W

- Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm².
- Device mounted on a ceramic PCB, Al₂O₃, standard footprint.



Transient thermal impedance from junction to ambient as a function of pulse duration; typical values Fig 2.

80 V, 4.0 A PNP low V_{CEsat} (BISS) transistor

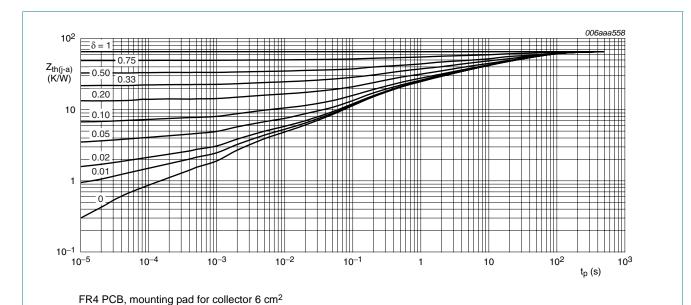


Fig 3. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

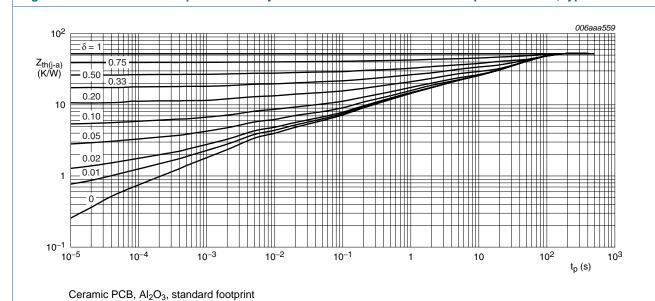


Fig 4. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

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80 V, 4.0 A PNP low V_{CEsat} (BISS) transistor

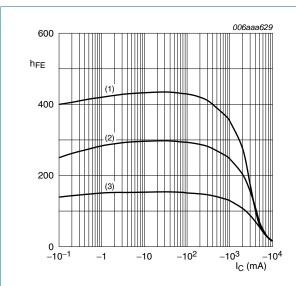
7. **Characteristics**

Characteristics

 $T_{amb} = 25$ °C unless otherwise specified.

Symbol	Parameter	Conditions	M	in Typ	Max	Unit
I _{CBO}	collector-base cut-off	$V_{CB} = -80 \text{ V}; I_E = 0 \text{ A}$	-	-	-100	nΑ
	current	$V_{CB} = -80 \text{ V}; I_E = 0 \text{ A};$ $T_j = 150 \text{ °C}$	-	-	-50	μΑ
I _{EBO}	emitter-base cut-off current	$V_{EB} = -5 \text{ V}; I_C = 0 \text{ A}$	-	-	-100	nA
h _{FE}	DC current gain	$V_{CE} = -2 \text{ V}; I_{C} = -0.5 \text{ A}$	[1] 20	00 280	-	
		$V_{CE} = -2 \text{ V}; I_{C} = -1 \text{ A}$	<u>[1]</u> 18	50 240	-	
		$V_{CE} = -2 \text{ V}; I_{C} = -2 \text{ A}$	<u>[1]</u> 12	20 190	-	
		$V_{CE} = -2 \text{ V}; I_{C} = -4 \text{ A}$	<u>[1]</u> 60	100	-	
		$V_{CE} = -2 \text{ V}; I_{C} = -5 \text{ A}$	[1] 4	5 70	-	
V _{CEsat} collector-emitter saturation voltage	$I_C = -0.5 \text{ A}; I_B = -50 \text{ mA}$	[1] _	-36	-50	mV	
	saturation voltage	$I_C = -1 A$; $I_B = -50 \text{ mA}$	<u>[1]</u> -	-70	-100	mV
		$I_C = -1 A$; $I_B = -10 \text{ mA}$	<u>[1]</u> -	-180	-250	mV
		$I_C = -2 \text{ A}; I_B = -40 \text{ mA}$	<u>[1]</u> -	-200	-280	mV
		$I_C = -4 \text{ A}; I_B = -200 \text{ mA}$	<u>[1]</u> -	-230	-330	mV
	$I_C = -4 \text{ A}; I_B = -400 \text{ mA}$	<u>[1]</u> -	-170	-240	mV	
	$I_C = -4.7 \text{ A}; I_B = -235 \text{ mA}$	<u>[1]</u> -	-300	-420	mV	
R _{CEsat}	collector-emitter	$I_C = -2 \text{ A}; I_B = -40 \text{ mA}$	<u>[1]</u> -	100	140	$m\Omega$
	saturation resistance	$I_C = -4 \text{ A}; I_B = -200 \text{ mA}$	<u>[1]</u> -	58	83	$m\Omega$
		$I_C = -4 \text{ A}; I_B = -400 \text{ mA}$	<u>[1]</u> -	43	60	$m\Omega$
V_{BEsat}	base-emitter	$I_C = -1 A$; $I_B = -100 \text{ mA}$	<u>[1]</u> -	-0.81	-0.9	V
	saturation voltage	$I_C = -4 \text{ A}; I_B = -400 \text{ mA}$	<u>[1]</u> -	-0.93	-1.05	V
V_{BEon}	base-emitter turn-on voltage	$V_{CE} = -2 \text{ V}; I_{C} = -2 \text{ A}$	[1] -	-0.78	-0.85	V
t _d	delay time	$V_{CC} = -12.5 \text{ V}; I_C = -3 \text{ A};$	-	15	-	ns
t _r	rise time	$I_{Bon} = -0.15 \text{ A};$ $I_{Boff} = 0.15 \text{ A}$	-	85	-	ns
t _{on}	turn-on time	1BOII - 0.10 / (-	100	-	ns
t _s	storage time		-	185	-	ns
t _f	fall time		-	100	-	ns
t _{off}	turn-off time		-	285	-	ns
f _T	transition frequency	$V_{CE} = -10 \text{ V; } I_{C} = -100 \text{ mA;}$ f = 100 MHz	-	100	-	MHz
C _c	collector capacitance	$V_{CB} = -10 \text{ V}; I_E = i_e = 0 \text{ A};$ f = 1 MHz	-	65	90	pF

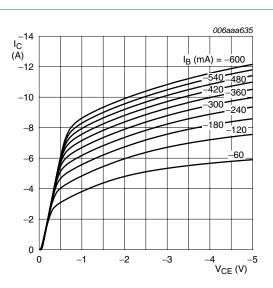
^[1] Pulse test: $t_p \leq 300~\mu s;~\delta \leq 0.02.$



$$V_{CE} = -2 V$$

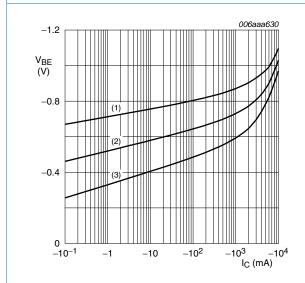
- (1) $T_{amb} = 100 \, ^{\circ}C$
- (2) $T_{amb} = 25 \, ^{\circ}C$
- (3) $T_{amb} = -55 \, ^{\circ}C$

Fig 5. DC current gain as a function of collector current; typical values



$$T_{amb} = 25 \, ^{\circ}C$$

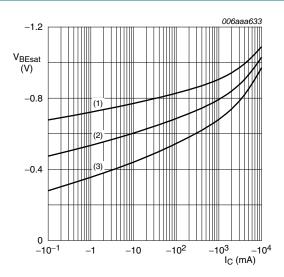
Fig 6. Collector current as a function of collector-emitter voltage; typical values





- (1) $T_{amb} = -55 \,^{\circ}C$
- (2) $T_{amb} = 25 \, ^{\circ}C$
- (3) $T_{amb} = 100 \, ^{\circ}C$

Base-emitter voltage as a function of collector Fig 7. current; typical values



$$I_{\rm C}/I_{\rm B}=20$$

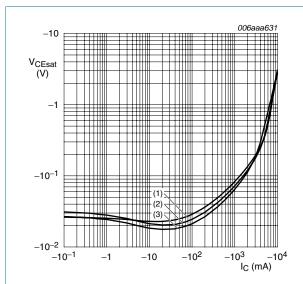
- (1) $T_{amb} = -55 \, ^{\circ}C$
- (2) $T_{amb} = 25 \, ^{\circ}C$
- (3) $T_{amb} = 100 \, ^{\circ}C$

Fig 8. Base-emitter saturation voltage as a function of collector current; typical values

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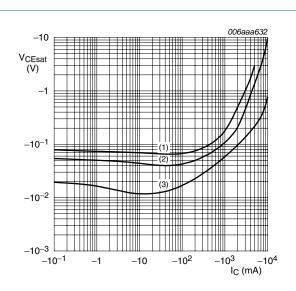
$$I_{\rm C}/I_{\rm B} = 20$$

(1)
$$T_{amb} = 100 \, ^{\circ}C$$

(2)
$$T_{amb} = 25 \, ^{\circ}C$$

(3)
$$T_{amb} = -55 \, ^{\circ}C$$

Fig 9. Collector-emitter saturation voltage as a function of collector current; typical values



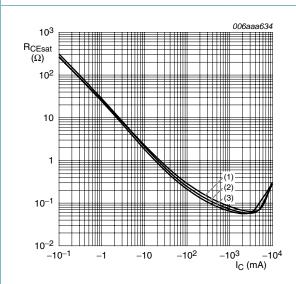
$$T_{amb} = 25 \, ^{\circ}C$$

(1)
$$I_C/I_B = 100$$

(2)
$$I_C/I_B = 50$$

(3)
$$I_C/I_B = 10$$

Fig 10. Collector-emitter saturation voltage as a function of collector current; typical values



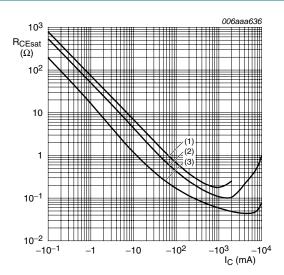
 $I_{\rm C}/I_{\rm B}=20$

(1)
$$T_{amb} = 100 \, ^{\circ}C$$

(2)
$$T_{amb} = 25 \, ^{\circ}C$$

(3)
$$T_{amb} = -55 \, ^{\circ}C$$

Fig 11. Collector-emitter saturation resistance as a function of collector current; typical values



$$T_{amb} = 25 \, ^{\circ}C$$

(1)
$$I_C/I_B = 100$$

(2)
$$I_C/I_B = 50$$

(3)
$$I_C/I_B = 10$$

Fig 12. Collector-emitter saturation resistance as a function of collector current; typical values

8. Test information

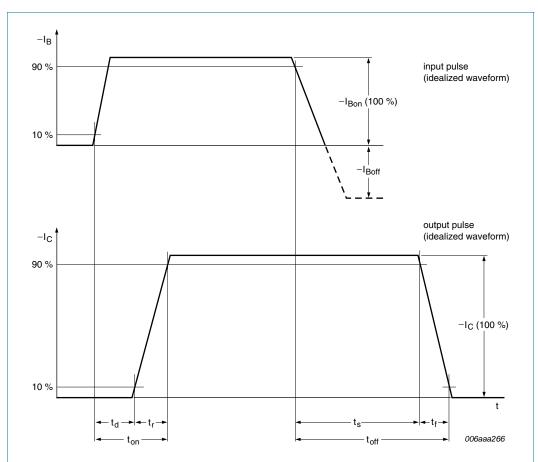


Fig 13. BISS transistor switching time definition

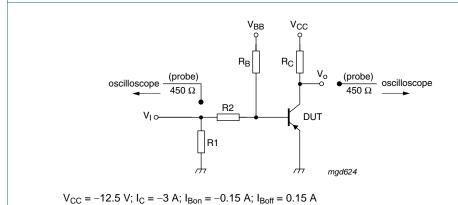
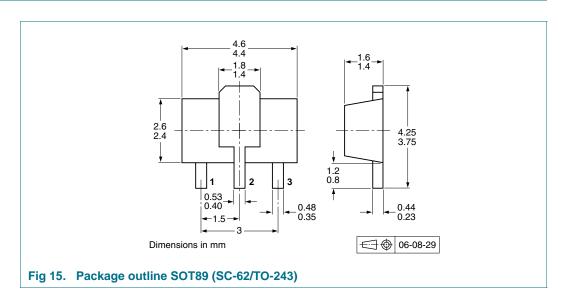


Fig 14. Test circuit for switching times

80 V, 4.0 A PNP low V_{CEsat} (BISS) transistor

9. Package outline



10. Packing information

Table 8. Packing methods

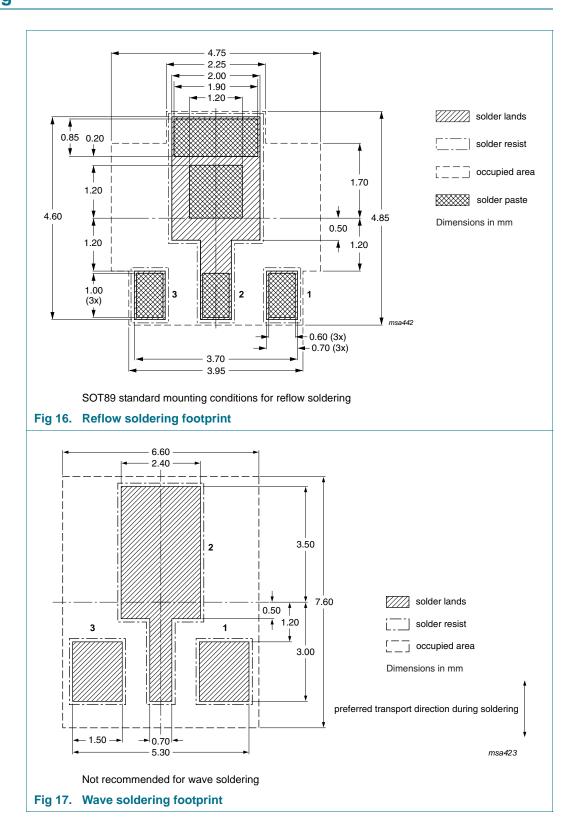
The indicated -xxx are the last three digits of the 12NC ordering code.[1]

Type number	Package	Description Packing quantity		ntity
			1000	4000
PBSS305PX	SOT89	8 mm pitch, 12 mm tape and reel	-115	-135

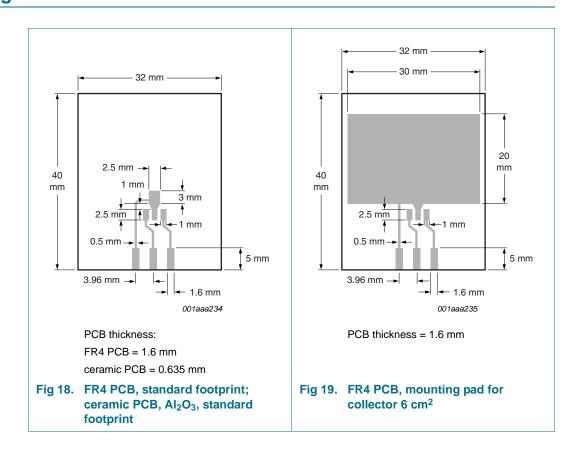
[1] For further information and the availability of packing methods, see $\underline{\text{Section 15}}$.

80 V, 4.0 A PNP low V_{CEsat} (BISS) transistor

11. Soldering



12. Mounting



PBSS305PX

80 V, 4.0 A PNP low V_{CEsat} (BISS) transistor

13. Revision history

Table 9. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PBSS305PX_2	20091208	Product data sheet	-	PBSS305PX_1
Modifications:		eet was changed to reflect the was changed to reflect the		
	Figure 15 "P	ackage outline SOT89 (SC-62	2/TO-243)": updated	
	Figure 16 "R	eflow soldering footprint": upd	ated	
	Figure 17 "W	lave soldering footprint": upda	ted	
PBSS305PX_1	20060822	Product data sheet	-	-

80 V, 4.0 A PNP low V_{CEsat} (BISS) transistor

14. Legal information

14.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
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- [2] The term 'short data sheet' is explained in section "Definitions".
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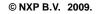
PBSS305PX

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